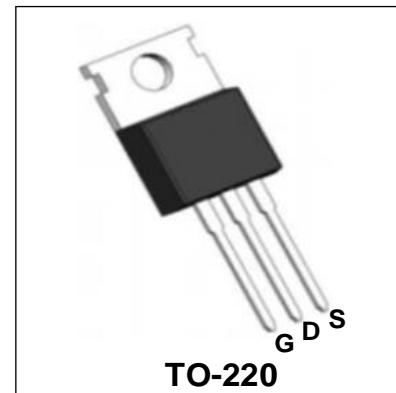


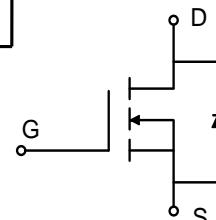
## 200V N-Channel Enhancement Mode Power MOSFET

**Description**

WMK340N20HG2 uses Wayon's 2<sup>nd</sup> generation power trench MOSFET technology that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance. This device is well suited for high efficiency fast switching applications.

**Features**

- $V_{DS} = 200V$ ,  $I_D = 50A$   
 $R_{DS(on)} < 34m\Omega$  @  $V_{GS} = 10V$
- High Speed Power Switching
- 100% EAS Guaranteed
- Low Gate Charge

**Applications**

- DC/DC Converter
- LED Backlighting
- Motor Control

**Absolute Maximum Ratings ( $T_A = 25^\circ C$ , unless otherwise noted)**

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	200	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current  $T_C = 25^\circ C$	$I_D$	50	A
$T_C = 100^\circ C$		31.6	
Pulsed Drain Current <sup>1</sup>	$I_{DM}$	200	A
Single Pulse Avalanche Energy <sup>2</sup>	$E_{AS}$	105.8	mJ
Total Power Dissipation	$P_D$	173.6	W
Operating Junction and Storage Temperature Range	$T_J$ , $T_{STG}$	-55 to 150	°C

**Thermal Characteristics**

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction-to-Ambient <sup>3</sup>	$R_{\theta JA}$	59	°C/W
Thermal Resistance from Junction-to-Case	$R_{\theta JC}$	0.72	°C/W

**Electrical Characteristics ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)**

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	200	-	-	V
Gate-Body Leakage Current	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current  $T_J=25^\circ\text{C}$	$I_{DSS}$	$V_{DS} = 200V, V_{GS} = 0V$	-	-	1	$\mu\text{A}$
$T_J=100^\circ\text{C}$			-	-	100	
Gate-Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2	3	4	V
Drain-Source on-Resistance <sup>4</sup>	$R_{DS(\text{on})}$	$V_{GS} = 10V, I_D = 8A$	-	27	34	$\text{m}\Omega$
Forward Transconductance <sup>4</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 10A$	-	32	-	S
<b>Dynamic Characteristics<sup>5</sup></b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 100V, V_{GS} = 0V, f = 1\text{MHz}$	-	1712	-	pF
Output Capacitance	$C_{oss}$		-	141	-	
Reverse Transfer Capacitance	$C_{rss}$		-	8	-	
Gate Resistance	$R_G$	$f = 1\text{MHz}$	-	3.4	-	$\Omega$
<b>Switching Characteristics<sup>5</sup></b>						
Total Gate Charge	$Q_g$	$V_{GS} = 10V, V_{DS} = 100V, I_D = 10A$	-	23	-	nC
Gate-Source Charge	$Q_{gs}$		-	8.2	-	
Gate-Drain Charge	$Q_{gd}$		-	2.4	-	
Turn-on Delay Time	$t_{d(on)}$	$V_{GS} = 10V, V_{DD} = 100V, R_G = 10\Omega, I_D = 10A$	-	14.5	-	ns
Rise Time	$t_r$		-	20	-	
Turn-off Delay Time	$t_{d(off)}$		-	26	-	
Fall Time	$t_f$		-	12.5	-	
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 10A, dI/dt = 100A/\mu\text{s}$	-	85	-	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	300	-	nC
<b>Drain-Source Body Diode Characteristics</b>						
Diode Forward Voltage <sup>4</sup>	$V_{SD}$	$I_S = 1A, V_{GS} = 0V$	-	-	1.2	V
Continuous Source Current	$T_C=25^\circ\text{C}$	$I_S$	-	-	50	A

Notes:

1. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .
2. The EAS data shows Max. rating . The test condition is  $V_{DD}=25V, V_{GS}=10V, L=0.4\text{mH}, I_{AS}=23A$ .
3. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
4. The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$ .
5. This value is guaranteed by design hence it is not included in the production test.

## Typical Characteristics

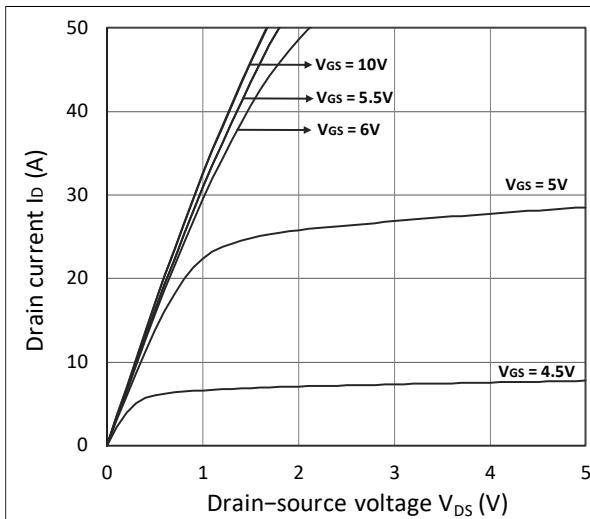


Figure 1. Output Characteristics

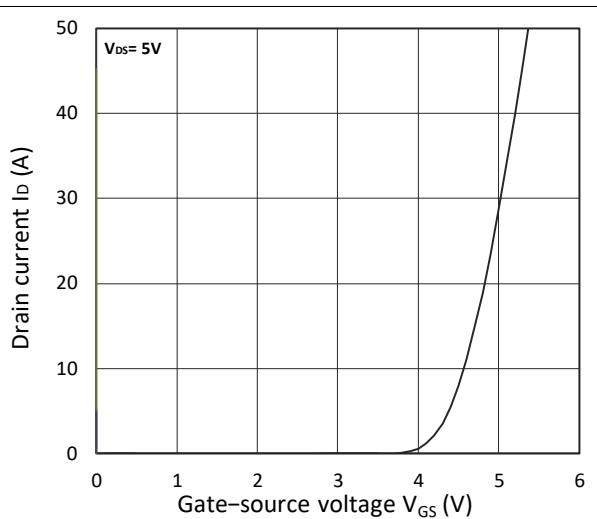


Figure 2. Transfer Characteristics

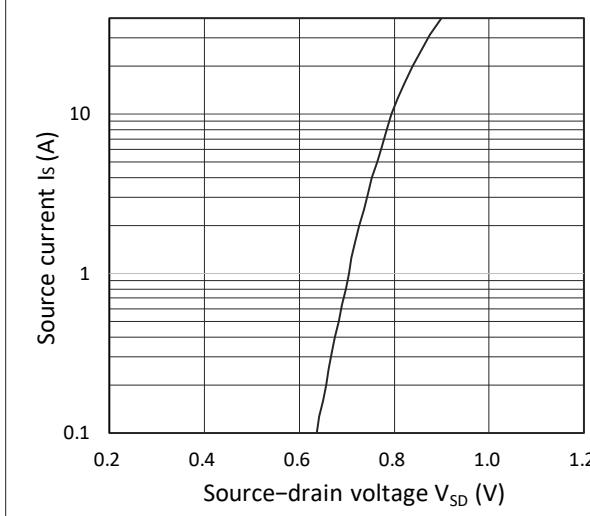
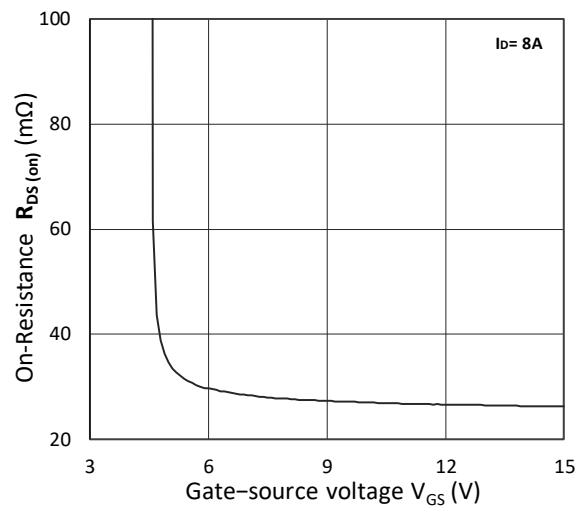
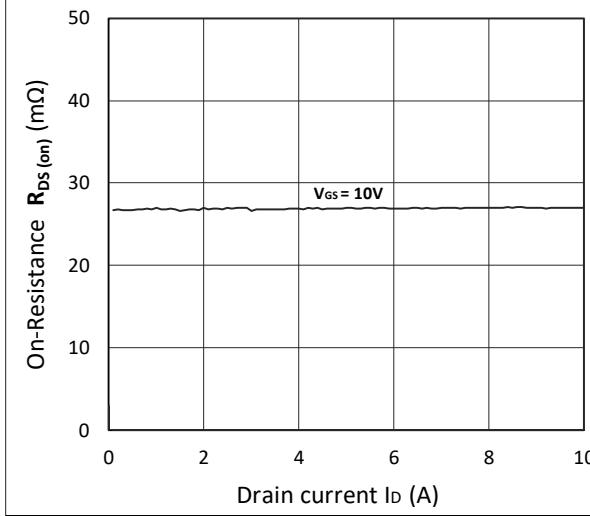
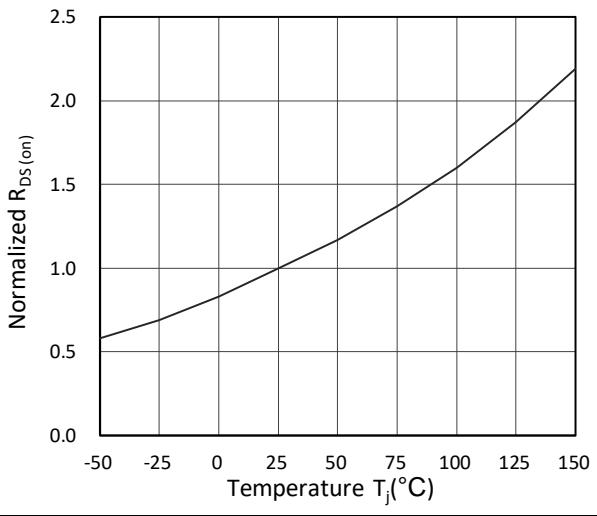


Figure 3. Forward Characteristics of Reverse

Figure 4.  $R_{DS(\text{ON})}$  vs.  $V_{GS}$ Figure 5.  $R_{DS(\text{ON})}$  vs.  $I_D$ Figure 6. Normalized  $R_{DS(\text{ON})}$  vs. Temperature

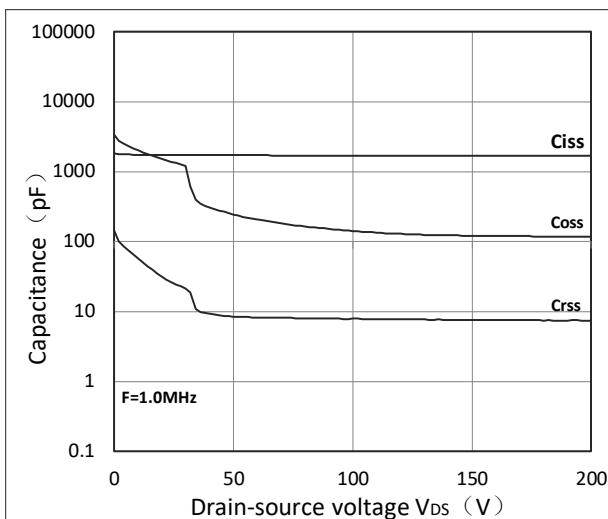


Figure 7. Capacitance Characteristics

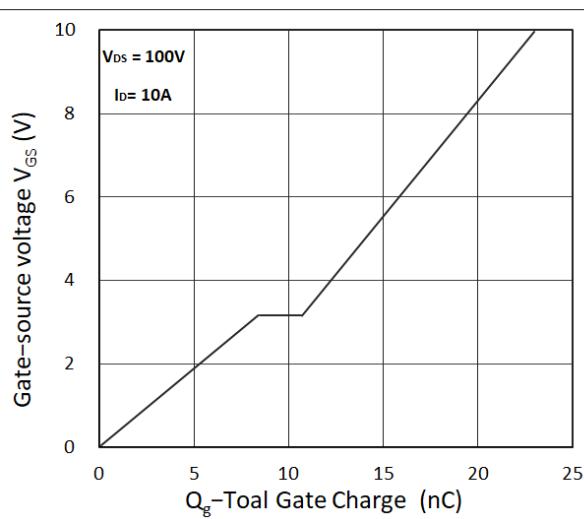


Figure 8. Gate Charge Characteristics

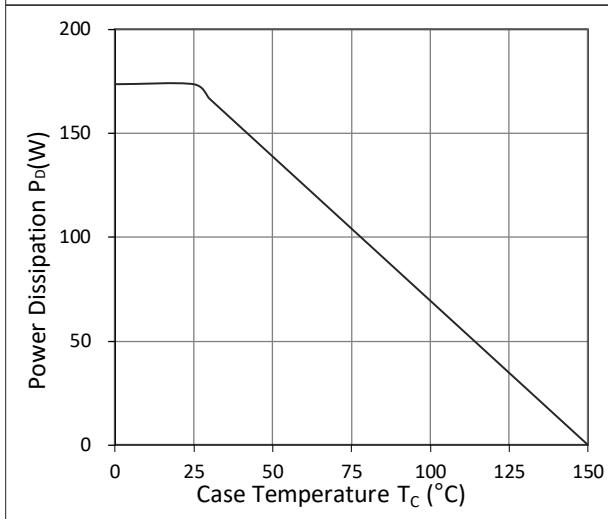


Figure 9. Power Dissipation

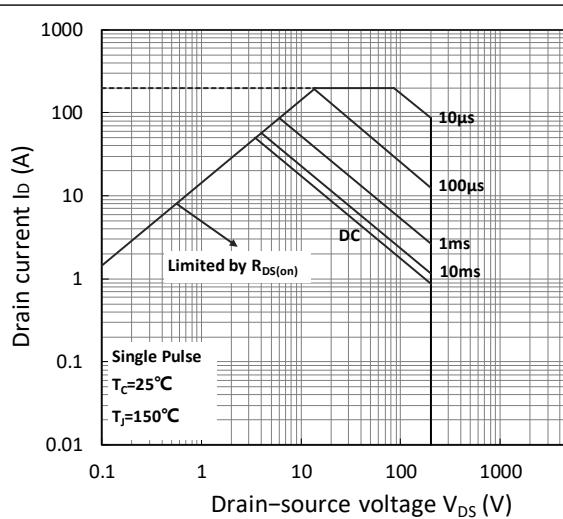


Figure10. Safe Operating Area

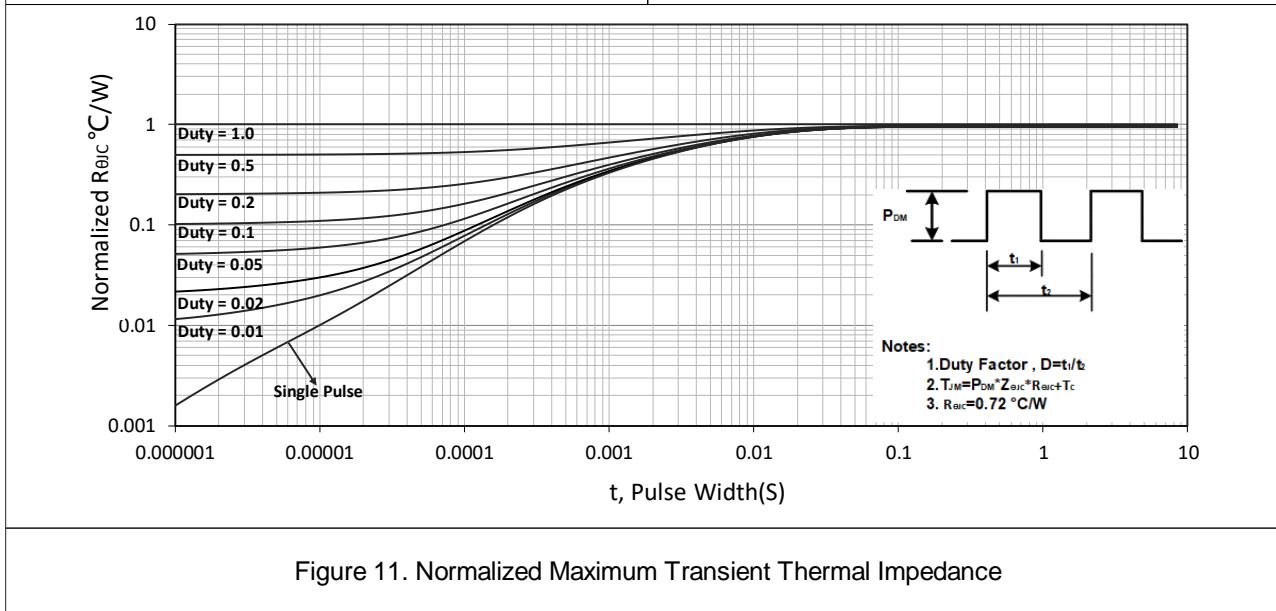
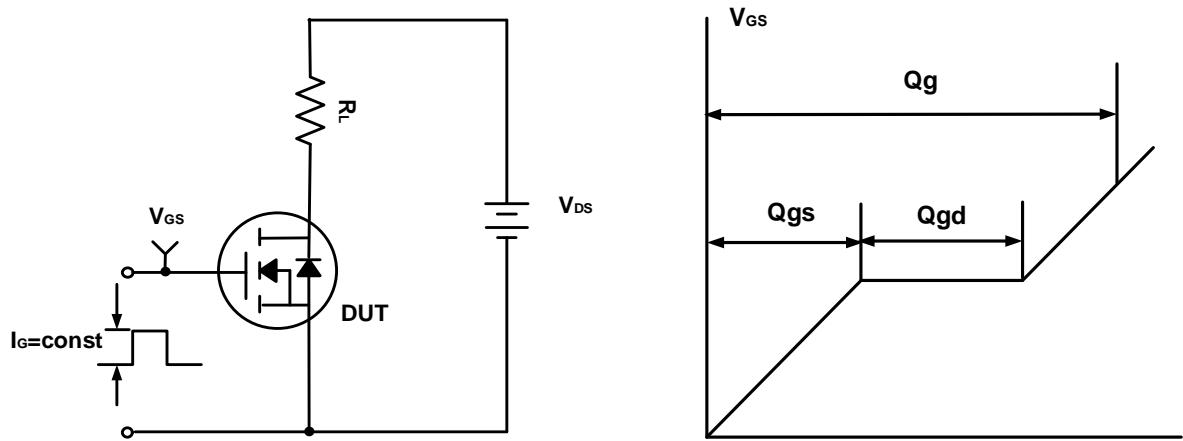
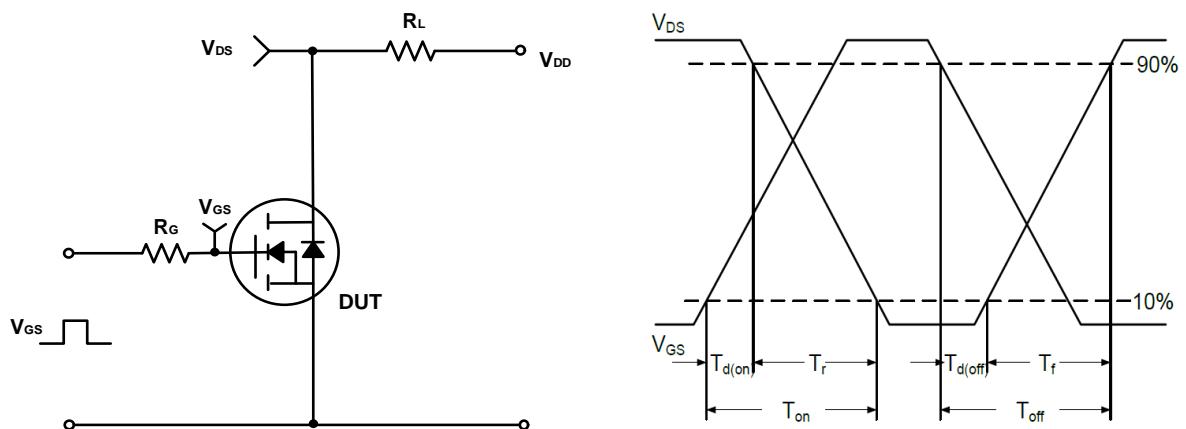
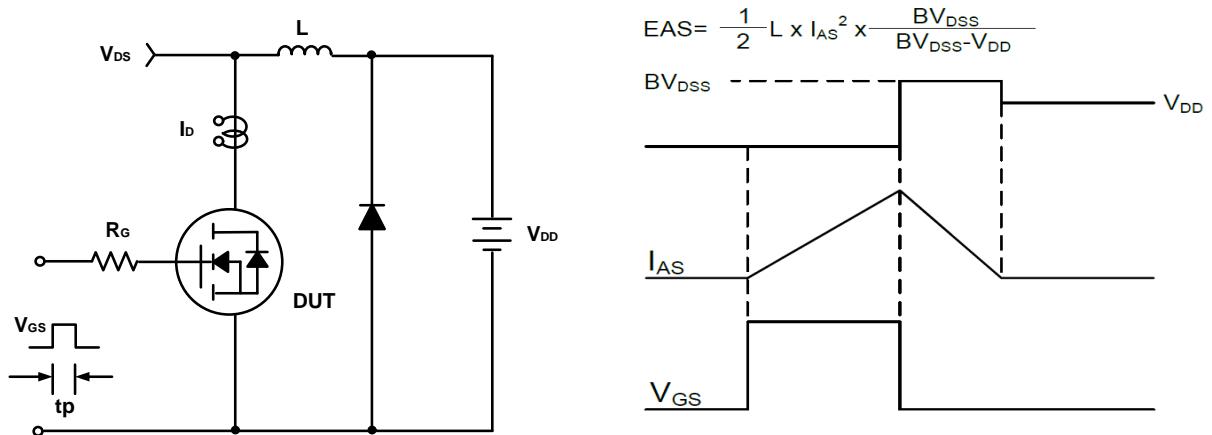
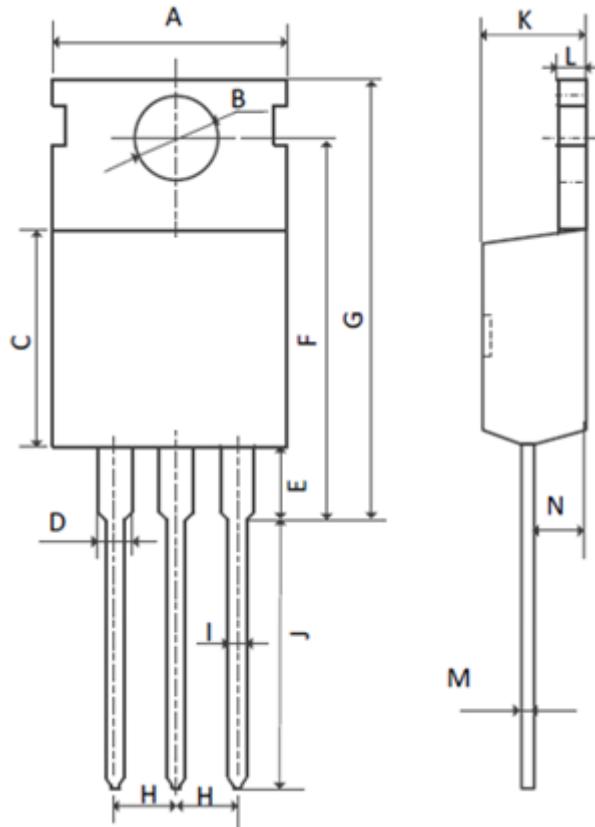


Figure 11. Normalized Maximum Transient Thermal Impedance

**Test Circuit****Figure A. Gate Charge Test Circuit & Waveforms****Figure B. Switching Test Circuit & Waveforms****Figure C. Unclamped Inductive Switching Circuit & Waveforms**

## Mechanical Dimensions for TO-220

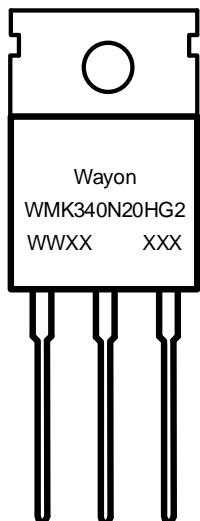
## COMMON DIMENSIONS



SYMBOL	MM	
	MIN	MAX
A	9.70	10.30
B	3.40	3.80
C	8.80	9.40
D	1.17	1.47
E	2.60	3.50
F	15.10	16.70
G	19.55MAX	
H	2.54REF	
I	0.70	0.95
J	9.35	11.00
K	4.30	4.77
L	1.20	1.45
M	0.40	0.65
N	2.20	2.60

**Ordering Information**

Part	Package	Marking	Packing method
WMK340N20HG2	TO-220	WMK340N20HG2	Tube

**Marking Information**

WMK340N20HG2 = Device code

WWXX XXX= Date code

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